Schottky Barrier Diode

DB2L33500L1

Panasonic

DB2L33500L1

For rectification

■ Features

- Average Forward Current IF(AV)

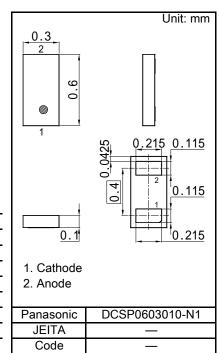
 ≤ 0.1 A rectification is possible
- Low Forward Voltage
- High power capability due to Chip Size Package RoHS compliant (EU RoHS / MSL:Level 1 compliant)
- Marking Symbol: C6

Packaging

Embossed type (Thermo-compression sealing): 1 000 pcs / reel (standard)

■ Absolute Maximum Ratings

Parameter	Symbol	Min	Max	Unit
Reverse Voltage *1	VR	-	30	V
Maximum Peak Reverse Voltage *1	VRM	-	30	V
Average Forward Current *2,3	IF(AV)	-	0.1	Α
Average Forward Current *2,4	IF(AV)	-	0.1	Α
Non-repetitive Peak Surge Forward Current *1,5	IFSM	-	3	Α
Operating Junction Temperature *6	Tj	-	150	°C
Ambient Temperature	Та	-40	+150	°C
Storage Temperature	Tstg	-55	+150	°C



Note) *1: Ta = Tj = 25°C

*2: Squre wave : $\sigma = 0.5$

*3: Ta ≤ 123°C, when device mounted on a FR4 PCB (25.4mm×25.4mm, 1mm thick), copper wiring (27.6mm² area, 36µm thick).

- *4: Tsp ≦ 148°C
- *5: Squre wave : Tp = 5 ms
- *6: Power derating is necessary so that Tj < 150°C.

(Waveform definition)	IF ↑ ← Tp
Duty Cycle : $\sigma = \frac{Tp}{T}$	Time
	Time

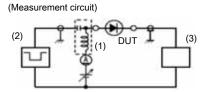
■ Electrical Characteristics Ta = 25 °C ± 3 °C

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Forward Voltage	VF	IF = 0.1 A	-	0.35	0.41	V
Reverse Current	IR	VR = 30 V	-	15	70	μA
Terminal Capacitance	Ct	VR = 10 V, f = 1 MHz	-	4.4	-	pF
Reverse Recovery Time *1	trr	IF = IR = 100 mA, Irr = 10 mA	-	1.6	-	ns

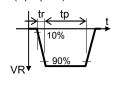
- Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7031 measuring methods for diodes.
 - 2. This product is sensitive to electric shock (static electricity, etc.).

Due attention must be paid on the charge of a human body and the leakage of current from the operating equipment.

3. *1: Measurement circuit, input pulse, output pulse for Reverse recovery time

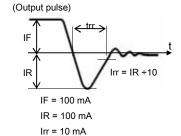


- (1) Bias Insertion Unit (N-50BU)
- (2) Pulse Generator (PG-10N), RS = 50Ω
- (3) Wave Form Analyzer (SAS-8130), Ri = 50 Ω



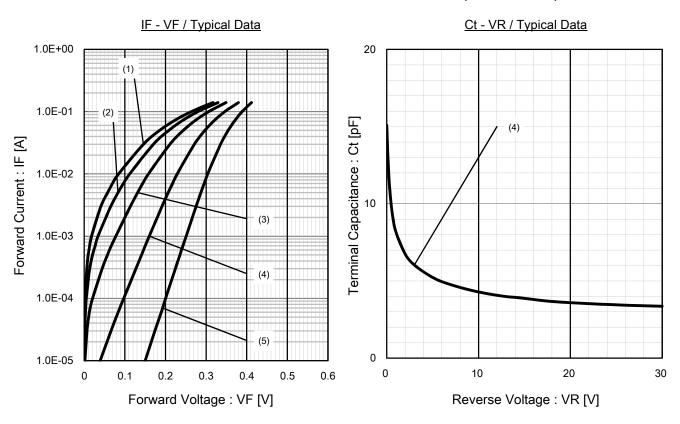
(Input pulse)

 $tp = 2 \mu s$ tr = 0.35 ns $\sigma = 0.05$

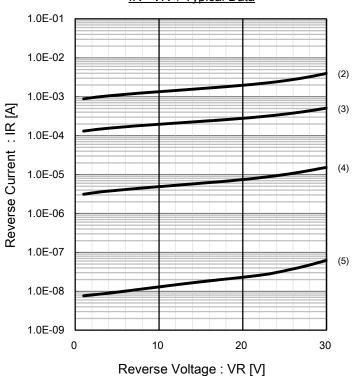


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Electrical Characteristics Technical Data (Reference)



IR - VR / Typical Data

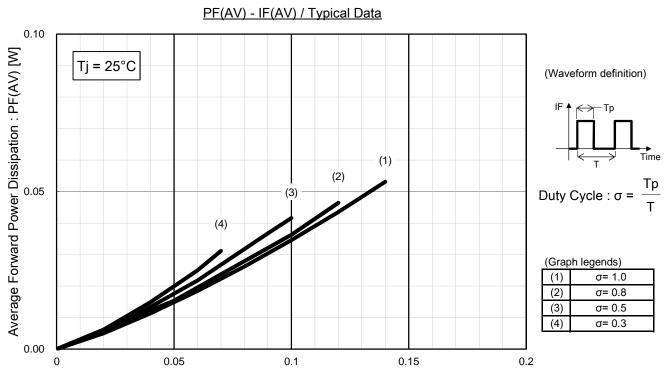


(Graph legends)

(Graph legerius)					
(1)	Ta =	150	°C		
(2)	Ta =	125	°C		
(3)	Ta =	85	°C		
(4)	Ta =	25	°C		
(5)	Ta =	-40	°C		

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Electrical Characteristics Technical Data (Reference)

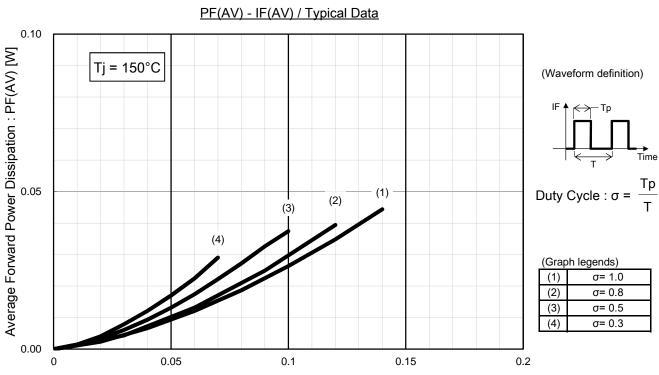


Average Forward Current : IF(AV) [A]

PR(AV) - VR / Typical Data 0.00060 Average Reverse Power Dissipation : PR(AV) [W] 0.00000 0.00000 0.000010 0.000010 (Waveform definition) Tj = 25°C (1) (2) Duty Cycle : $\sigma = \frac{Tp}{T}$ (3) (Graph legends) σ= 1.0 σ= 0.7 (4) σ= 0.5 (3)(4) σ = 0.2 0.00000 5 10 30 35

Reverse Voltage: VR [V]

Electrical Characteristics Technical Data (Reference)



Average Forward Current : IF(AV) [A]

PR(AV) - VR / Typical Data 0.16 Average Reverse Power Dissipation: PR(AV) [W] Tj = 125°C 0.14 (Waveform definition) 0.12 (1) 0.10 (2) Duty Cycle : $\sigma = \frac{Tp}{T}$ 0.08 0.06 (3) (Graph legends) 0.04 σ= 1.0 σ= 0.7 (4) σ= 0.5 0.02 (3) (4) σ = 0.2 0.00 5 10 15 30 35

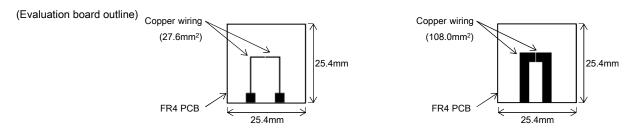
Reverse Voltage: VR [V]

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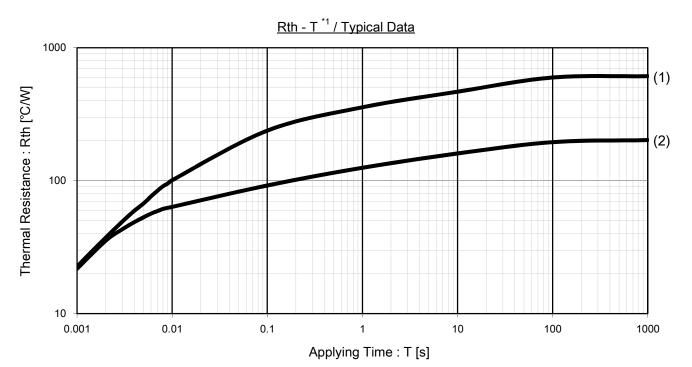
■ Thermal Characteristics

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Thermal Resistance, Junction to Splder Point	$R_{th(j-sp)}$	Ta = 25°C, in free air	-	35	1	°C/W
Thermal Resistance, Junction to Ambient *1	R _{th(j-a)}	Ta = 25°C, in free air	-	610	ı	°C/W
Thermal Resistance, Junction to Ambient *2	$R_{th(j-a)}$	Ta = 25°C, in free air	-	202	-	°C/W

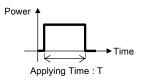
- Note) *1: Device mounted on a FR4 PCB (25.4mm×25.4mm, 1mm thick), copper wiring (27.6mm² area, 36µm thick).
 - *2: Device mounted on a FR4 PCB (25.4mm×25.4mm, 1mm thick), copper wiring (108.0mm² area, 36µm thick).



Thermal Characteristics Technical Data (Reference)



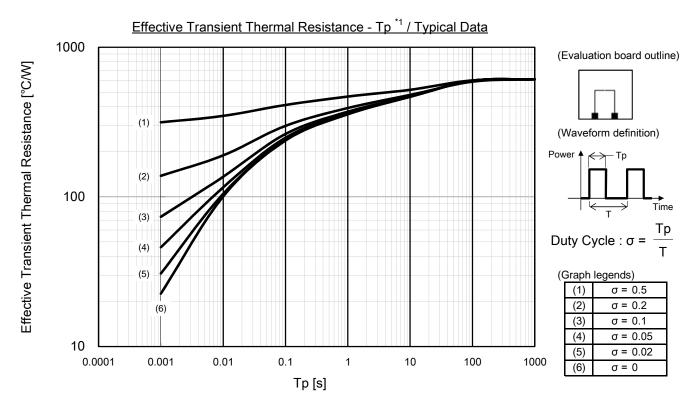
Note) *1: Single pulse measurement (Waveform definition)



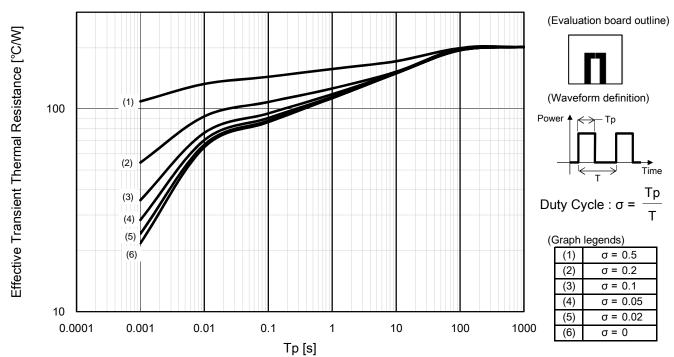
(Graph legends)

		Device mounted on a FR4 PCB (25.4mm×25.4mm, 1mm thick),
l	(1)	copper wiring (27.6mm ² area, 36µm thick).
(2)		Device mounted on a FR4 PCB (25.4mm, 1mm thick),
(2)	(2)	copper wiring (108.0mm ² area, 36µm thick).

Thermal Characteristics Technical Data (Reference)

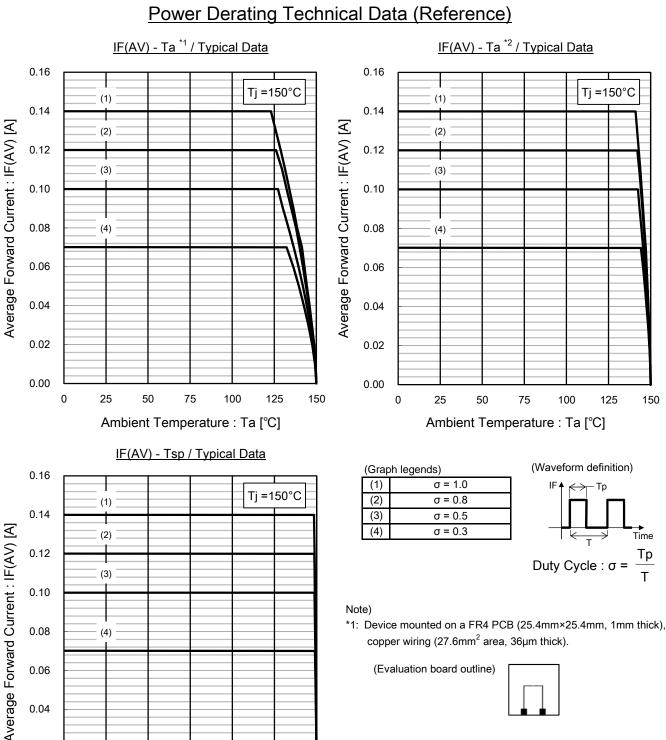


Effective Transient Thermal Resistance - Tp *2 / Typical Data



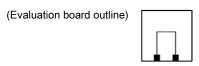
Note) *1: Device mounted on a FR4 PCB (25.4mm×25.4mm, 1mm thick), copper wiring (27.6mm² area, 36µm thick).

^{*2:} Device mounted on a FR4 PCB (25.4mm, 1mm thick), copper wiring (108.0mm² area, 36µm thick).



150

copper wiring (27.6mm² area, 36µm thick).



*2: Device mounted on a FR4 PCB (25.4mm×25.4mm, 1mm thick), copper wiring (108.0mm² area, 36µm thick).

(Evaluation board outline)

25 50 75 100 125 Solder Point Temperature: Tsp [°C]

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Established: 2015-10-13

0.06

0.04

0.02

0.00

Schottky Barrier Diode

DB2L33500L1

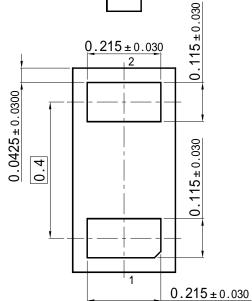
Unit: mm

Panasonic

DCSP0603010-N1

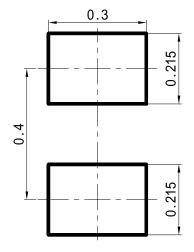
0.30±0.03 2 80.0 10.00 10.00

0.10±0.02



■ Land Pattern (Reference)

Unit: mm



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